

Search Notes

Application/Control No.

10/627,782

Examiner

John D. Lee

Applicant(s)/Patent under
Reexamination

KAWANISHI ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
359	326-332	5/19/2005	JDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO "WEST" Database searched; search strategy on separate sheet.	5/19/2005	JDL